

# 27HC1616

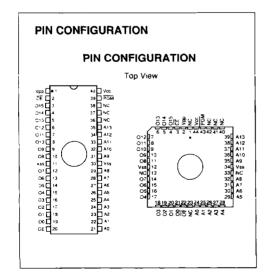
### 256K (16K x 16) High Speed CMOS UV Erasable PROM

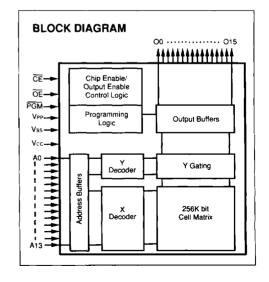
#### **FEATURES**

- High speed performance
   Assessment 1
  - -45ns Maximum access time
- CMOS Technology for low power consumption —90mA Active current
  - -100µA Standby current (low power option)
- · OTP (one time programming) available
- WordWide architecture offers space saving over Bytewide memories
- Two programming algorithms allow improved programming times
  - -Fast programming
  - --Express
- · Organized 16K x 16: JEDEC standard pinouts
  - -40-Pin dual in line package
  - -44-Pin chip carrier (leadless or plastic)
- · Extended temperature ranges available:
  - -Commercial: 0° C to 70° C
  - -Industrial: -40° C to 85° C
  - -Military\*\*: -55° C to 125' C

#### DESCRIPTION

The Microchip Technology Inc. 27HC1616 is a CMOS 256K bit (ultraviolet light) Erasable (electrically) Programmable Read Only Memory. The device is organized as 16K words of 16 bits each. Advanced CMOS technology allows bipolar speed with a significant reduction in power. A low power option (L) allows further standby power reduction to 100µA. The 27HC1616 is configured in the JEDEC WordWide pinout which allows a two for one package savings over Bytewide memories along with a significant PC board savings. This very high speed single chip solution is ideal for 16/32 bit digital signal processors (DSP) or other sophisticated microprocessors. A complete family of packages is offered to provide the utmost flexibility. One Time Programming (OTP) is available for low cost (plastic) applications.





<sup>\*\*</sup> See 27HC1616 Military Data sheet DS60038

PIN FL	PIN FUNCTION TABLE								
Name	Function								
A0 - A13 CE OE PGM VPP O0 - O15 Vcc Vss NC	Address Inputs Chip Enable Output Enable Program Enable Programming Voltage Data Output +5V Power Supply Ground No Connection; No Internal Connection								

## ELECTRICAL CHARACTERISTICS Maximum Ratings\*

Vcc and input voltages w.r.t. Vss .....-0.6V to +7.25V VPP voltage w.r.t. Vss during programming .....-0.6V to +14.0V Voltage on A9 w.r.t. Vss ....-0.6V to +13.5V Output voltage w.r.t. Vss ....-0.6V to Vcc +1.0V Temperature under bias ....-65°C to 125° C Storage temperature ....-65°C to 150° C ESD protection on all pins ....-2KV

\*Notice: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

### READ OPERATION DC Characteristics

 $Vcc = +5V \pm 10\%$ 

Commercial: Tamb= 0° C to 70° C Industrial: Tamb= -40° C to 85° C

Status Symbol Max Units Conditions Parameter Part\* Min Logic "1" VIH Vcc+1 Input Voltages all 2.0 V Logic "0" VIL 8.0 -0.1 10 μΑ ViN = -0.1 to VCC + 1.0VInput Leakage all ILI -10 Vон ٧ all Logic "1" 2.4 IOH = -2mA**Output Voltages** Logic "0" VOL 0.45 V lol = 8mAVout = -0.1 to Vcc + 1.0V 10 цΑ Output Leakage all ILO -10 VIN = 0V: Tamb = 25° C: Cin 6 ρF Input Capacitance all f = 1MHzСоит 12 Vout = 0V:Tamb= 25° C: **Output Capacitance** all f = 1MHzTTL input ICC1 90 mΑ VCC = 5.5V; VPP = VCC Power Suppy Current. all f = 2MHz: Active OE = CE = VIL: lout = 0mA;  $V_{IL} = -0.1 \text{ to } 0.8 \text{ V}$ : VIH = 2.0 to VCC: Note 1 50 Power Supply Current, S.SX ICC(S)1 mΑ Standby 3 TTL input ICC(S)2 mΑ Power Supply Current, L. LX **CMOS** input 100 μΑ  $\overline{CE} = Vcc \pm 0.2V$ L, LX Standby VPP = 5.5V Read Mode 100 μА IPP Read Current all IPP Read Mode Note 2 VPP Vcc-0.7 Vcc VPP Read Voltage

<sup>\*</sup> Parts:

S = Standard Power; L = Low Power; X = Industrial Temp Range;

Notes: (1) AC Power component above 2MHz: 2mA/MHz.

<sup>(2)</sup> Vcc must be applied simultaneously or before VPP and be removed simultaneously or after VPP.

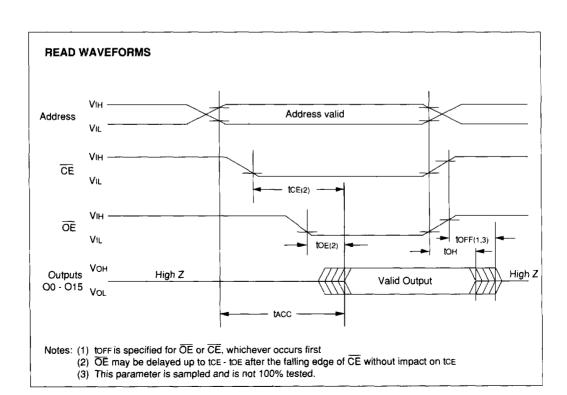
**READ OPERATION** AC Testing Waveform: VIH= 3.0 V and VIL= 0.0 V; VOH = VOL = 1.5 V

AC Characteristics Output Load: 1 TTL Load + 30 pF

Input Rise and Fall Times: 5 nsec

Ambient Temperature: Commercial: Tamb= 0° C to 70° C
Industrial: Tamb= -40° C to 85° C

Parameter	Part*	Sym	27HC1616-45		27HC1616-55		27HC1616-70		Units	Conditions	
			Min	Max	Min	Max	Min	Мах			
Address to Output Delay	all	tACC		45		55		70	ns	CE = OE = VIL	
CE to Output Delay	L S	tCE1	-	45 30		55 35		70 45	ns	OE = VIL	
OE to Output Delay	all	tOE		25		30		35	ns	CE = VIL	
CE or OE to O/P High Impedance	all	toff	0	20	0	20	0	25	ns		
Output Hold from Address CE or OE, which- ever occurs first	ail	tон	0		0		0		ns		



\* Parts: S = Standard Power: L = Low Power

PROGRAMMING DC Characteristics	Ambient Temperature: 25° C ±5° C For VPP and Vcc Voltages refer to Programming Algorithms								
Parameter	Status	Symbol	Min	Max	Units	Conditions			
Input Voltages	Logic "1" Logic "0"	VIH VIL	2.0 -0.1	Vcc+1 0.8	> <				
Input Leakage		lu	-10	10	μА	VIN =1V to VCC + 1.0V			
Output Voltages	Logic "1" Logic "0"	Voh Vol	2.4	0.45	V V	IOH = - 2mA IOL = 8mA			
Vcc Current, program & verify		Icc		90	mA	Note 1			
VPP Current,program		IPP		50	mA	Note 1			
A9 Product Identification		VH	11.5	12.5	٧				

Note: (1) Vcc must be applied simultaneously or before VPP and removed simultaneously or after VPP

PROGRAMMING
AC Characteristics

Output Load:

AC Testing Waveform: VIH = 2.4V; VIL = 0.45V; VOH = 2.0V and VOL = 0.8V 1 TTL Load + 100 pF

Ambient Temperature: 25° C ±5° C

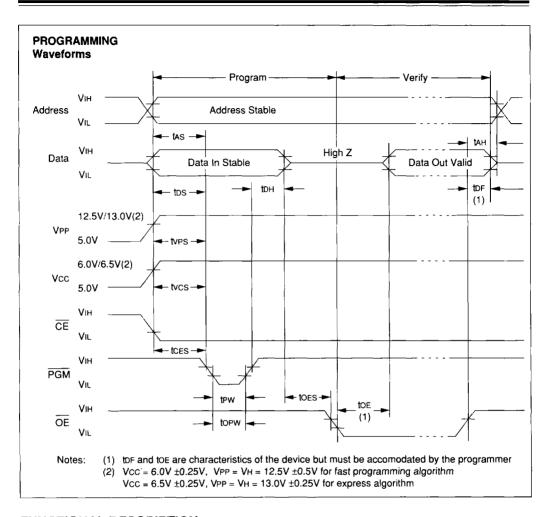
for Program, Program Verify and Program Inhibit Modes

For VPP and Vcc Voltages, refer to Programming Algorithms

Parameter	Symbol	Min	Max	Units	Remarks
Address Set-Up Time	tas	2		μs	
Data Set-Up Time	tos	2		μs	
Data Hold Time	tDH	2		μs	
Address Hold Time	tah	0		μs	
Float Delay (3)	tDF	0	130	ns	
Vcc Set-Up Time	tvcs	2		μs	
Program Pulse Width (1)	tpw	0.95	1.05	ms	1 ms typical
Program Pulse Width (1)	tPW	95	105	μs	100 μs typical
CE Set-Up Time	tces	2		μs	
OE Set-Up Time	toes	2		μs	
VPP Set-Up Time	tvps	2		μs	
Overprogram Pulse Width (2)	topw	2.85	78.75	ms	
Data Valid from OE	toE		100	ns	

Notes: (1) For express algorithm, initial programming width tolerance is 100 µsec ±5%. For fast programming algorithm, initial program pulse width tolerance is 1 msec ± 5%.

- (2) For fast programming algorithm, the length of the overprogram pulse may vary from 2.85 to 78.75 msec as a function of the iteration counter value.
- (3) This parameter is only sampled and not 100% tested. Output float is defined as the point where data is no longer driven (see timing diagram).



#### **FUNCTIONAL DESCRIPTION**

The 27HC1616 has the following functional modes:

- —Operation: The 27HC1616 can be activated for data read, be put in standby mode to lower its power consumption, or have the outputs disabled.
- —Programming: To receive its permanent data, the 27HC1616 must be programmed. Both a program and program/verify procedure is available. It can be programmed with Fast or Express algorithm.

The programming equipment can automatically recognize the device type and manufacturer using the identity mode.

For the general characteristics in these operation and programming modes, refer to the table.

Operation Mode	CE	ŌĒ	PGM	VPP	Α9	O0 - O15
Read	VIL	VIL	ViH	Vcc	х	Dout
Program	VIL	ViH	VIL	Vн	Х	Din
Program Verify	Vін	VIL	ViH	Vн	X	Dout
Program Inhibit	۷ιн	X	X	Vн	Х	High Z
Standby	VIH	Х	Х	Vcc	X	High Z
Output Disable	Х	۷ιн	Vін	Vcc	X	High Z
Identity	VIL	VIL	ViH	Vcc	Vн	Identity Code

X = Don't Care VH = 12.0 ±0.5V

#### **OPERATION**

#### Read Mode

For timing and AC characteristics refer to the tables Read Waveforms and Read Operation AC Characteristics.

The 27HC1616's memory data is accessed when

- —the chip is enabled by setting the CE pin low.
- —the data is gated to the output pins by setting the OE pin low.

For Read operations on the Low Power version, once the addresses are stable, the address access time (tAcc) is equal to the delay from CE to output (tCE). A faster CE access time (tCE) is available on the standard part to provide the additional time for decoding the CE signal. Data is transferred to the output after a delay (tOE) from the falling edge of OE.

#### Standby Mode

The standby mode is entered when the CE pin is high, and the program mode is not defined. When these conditions are met, the supply current will drop from 90mA to  $100\mu A$  on the low power part, and to 50mA on the standard part.

#### **Output Disable**

This feature eliminates bus contention in multiple bus microprocessor systems. The outputs go to a high impedance when the  $\overline{OE}$  pin is high, and the program mode is not defined.

#### Programming/Verification

The 27HC1616 has to be programmed, and afterward the programmed information verified. Before these operations, the Identity Code can be read to properly set up automated equipment. Multiple devices in parallel can be programmed using the programming and inhibit modes.

#### **Programming Algorithms**

Two programming algorithms are available: fast programming and express.

The fast programming algorithm is the industry standard programming mode that requires both initial programming pulses and overprogramming pulses. A flowchart of the algorithm is shown in Figure 1.

The express algorithm has been developed to improve programming through-put times in a production environment. Up to 10 pulses of 100µsec each are applied until the byte is verified. No overprogramming is required. A flowchart of this algorithm is shown in Figure 2.

The programming mode is entered when:

- a) Vcc is brought to the proper level
- b) VPP is brought to the proper VH level
- c) the OE pin is high
- d) the CE pin is low, and
- e) the PGM pin is pulsed low.

Since the erase state is "1" in the array, programming of "0" is required. The address of the memory location to be programmed is set via pins A0 - A13, and the data is presented to pins O0 - O15. When data and address are stable, a low going pulse on the CE line programs that memory location.

#### Verify

After the array has been programmed, it must be verified to make sure that all the bits have been correctly programmed. This mode is entered when all of the following conditions are met:

- a) Vcc is at the proper level
- b) VPP is at the proper VH level
- c) the OE line is low
- d) the CE pin is low, and
- e) the PGM line is high.

#### **Inhibit Mode**

When Programming multiple devices in parallel with different data only PGM needs to be <u>under</u> separate control to each device. By pulsing the PGM line low on a particular device, that device will be <u>programmed</u>, and all other devices with corresponding PGM or CE held high will not be programmed with the data although address and data are available on their input pins.

#### **Identity Mode**

In this mode specific data is read from the device that identifies the manufacturer as Microchip Technology, and the device type. This mode is entered when pin A9 is taken to VH (11.5V to 12.5V). The CE and OE pins must be at VIL. A0 is used to access any of the two nonerasable bytes whose data appears on O0 - O7.

Pin —	Input	Output*								
Identity	A0	O 7	O 6	O 5	O 4	O 3	O 2	0	0	H e x
Manufacturer Device Type*	Vil Vih	0	0	1 0	0	1 0	0	0	1	29 97

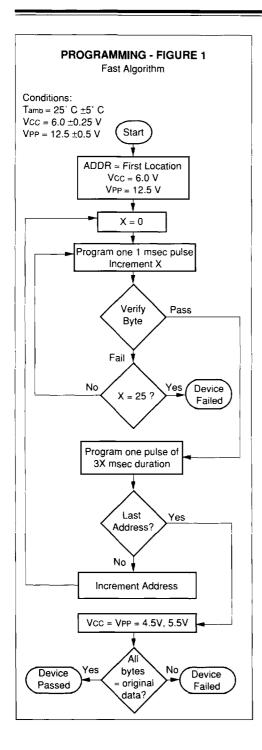
\*Code subject to change.

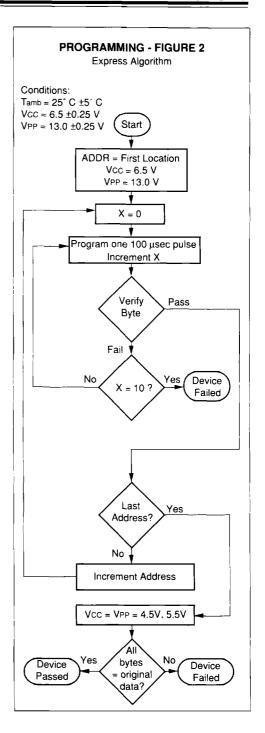
Note: O15 - O8 are 00 for the manufacturer and device type code.

#### **Erasure**

Windowed products offer the ability to erase the memory array. The memory matrix is erased to the all "1"s state as a result of being exposed to ultra-violet light at wavelengths  $\leq 4000$  Angstroms (Å). The recommended procedure is to expose the erasure window of device to a commercial UV source emitting at 2537Å with an intensity of 12,000µW/cm² at 1". The erasure time at that distance is about 15 to 20 min.

Note: Fluorescent lights and sunlight emit rays at the specified wavelengths. The erasure time is about 3 years or 1 week resp. in these cases. To prevent loss of data, an opaque label should be placed over the erasure window.





#### **SALES AND SUPPORT**

To order or to obtain information, e.g., on pricing or delivery, please use the listed part numbers, and refer to the factory or the listed sales offices.

